

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HEER ET AL.	
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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-WO98/33380	08-1998	Wolfgang et al.	A01N 43/40
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP2002-316903-A	10-2002	JP	Hisanari	A01N 43/64
O	WO98/33380	08-1998		Wolfgang et al.	A01N 43/40
P					
Q					
R					
S					
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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